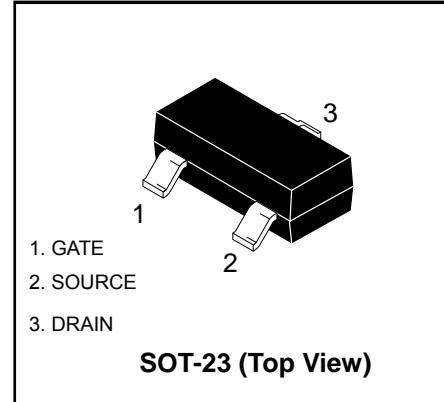
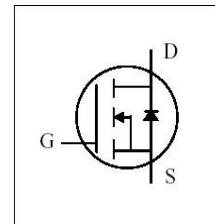


## 19V N-Channel Enhancement Mode MOSFET

**V<sub>DS</sub>= 19V****R<sub>D(S)</sub>(ON), V<sub>Gs</sub>@ 4.5V, I<sub>Ds</sub>@ 2.0A <60mΩ****R<sub>D(S)</sub>(ON), V<sub>Gs</sub>@ 2.5V, I<sub>Ds</sub>@ 1.0A < 80mΩ****Features**

Advanced trench process technology

High Density Cell Design For Ultra Low On-Resistance



## Maximum Ratings and Thermal Characteristics (TA = 25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	19	V
Gate-Source Voltage	V <sub>GS</sub>	±10	
Continuous Drain Current	I <sub>D</sub>	2.0	A
Pulsed Drain Current <sup>1)</sup>	I <sub>DM</sub>	6	
Maximum Power Dissipation <sup>2)</sup>	P <sub>D</sub>	0.6	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C

## Notes

1) Pulse width limited by maximum junction temperature.

2) Surface Mounted on FR4 Board, t ≤ 5 sec.

## ELECTRICAL CHARACTERISTICS

Parameter	Symbol	Test Condition	Min.	Typ.	Miax.	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	19			V
Drain-Source On-State Resistance <sup>1)</sup>	$R_{DS(on)}$	$V_{GS} = 4.5V, I_D = 2A$			60	$m\Omega$
		$V_{GS} = 2.5V, I_D = 1A$			80	
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	0.4		1.1	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 16V, V_{GS} = 0V$			1	$\mu A$
Gate Body Leakage	$I_{GSS}$	$V_{GS} = 10V, V_{DS} = 0V$			100	nA
Forward Transconductance <sup>1)</sup>	$g_{fs}$	$V_{DS} = 5V, I_D = 2.0A$		10	—	S
<b>Dynamic</b>						
Total Gate Charge	$Q_g$	$V_{DS} = 10V, I_D = 2.0A$ $V_{GS} = 4.5V$		5.4		nC
Gate-Source Charge	$Q_{gs}$			0.65		
Gate-Drain Charge	$Q_{gd}$			1.6		
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 10V, RL = 5.5\Omega$ $I_D \approx 2.0A, V_{GEN} = 4.5V$ $R_G = 6\Omega$		12		ns
Turn-On Rise Time	$t_r$			36		
Turn-Off Delay Time	$t_{d(off)}$			34		
Turn-Off Fall Time	$t_f$			10		
Input Capacitance	$C_{iss}$	$V_{DS} = 10V, V_{GS} = 0V$ $f = 1.0 \text{ MHz}$		340		pF
Output Capacitance	$C_{oss}$			115		
Reverse Transfer Capacitance	$C_{rss}$			33		
Diode Forward Voltage	$V_{SD}$	$I_S = 1.0A, V_{GS} = 0V$			1.2	V

<sup>1)</sup> Pulse test: pulse width <= 300us, duty cycle<= 2%

### Typical Electrical and Thermal Characteristics

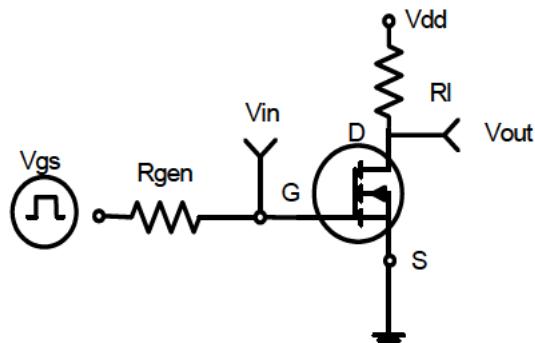


Figure 1:Switching Test Circuit

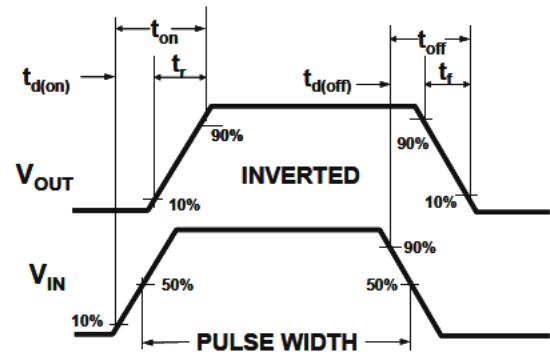


Figure 2:Switching Waveforms

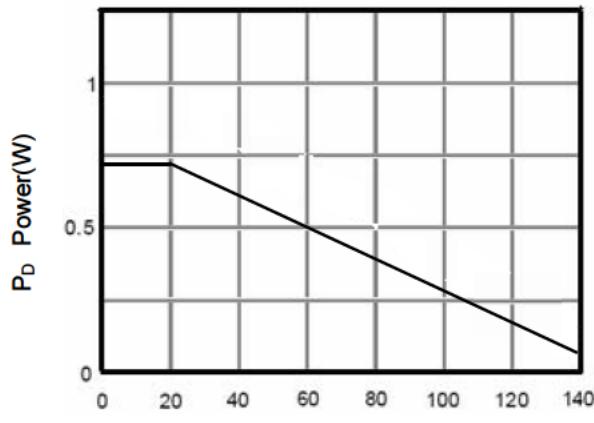


Figure 3 Power Dissipation

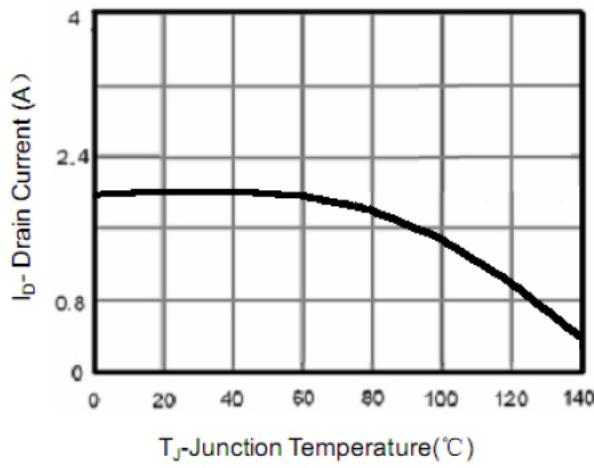


Figure 4 Drain Current

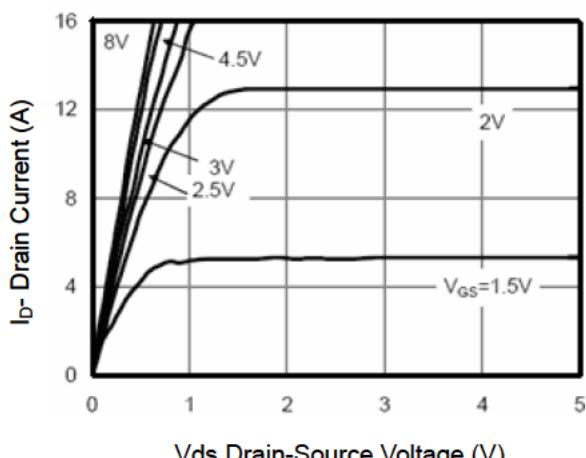


Figure 5 Output Characteristics

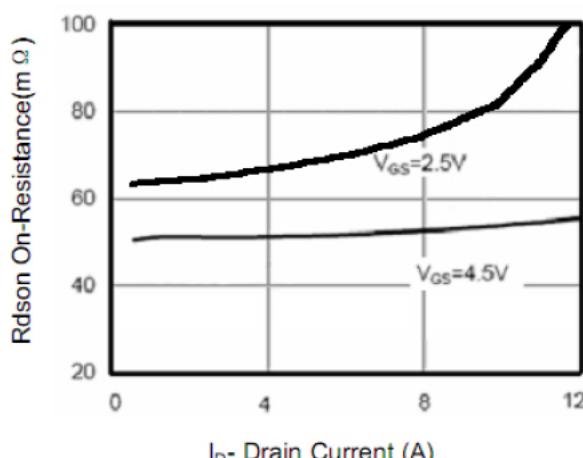
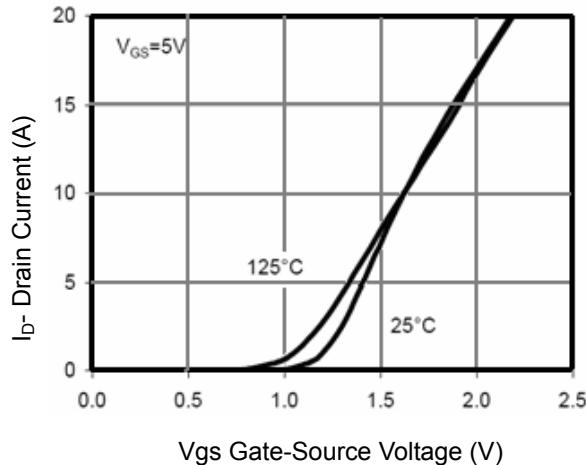
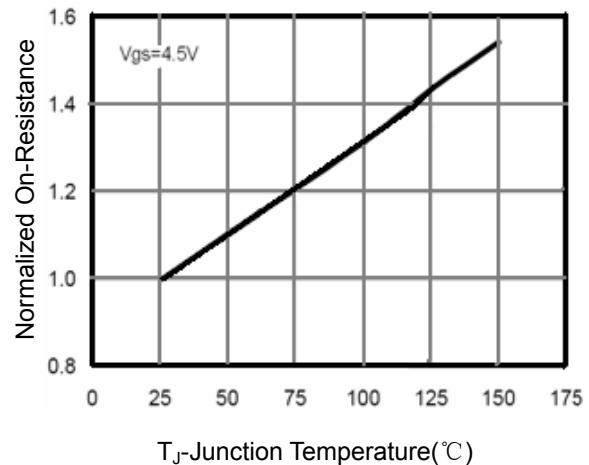
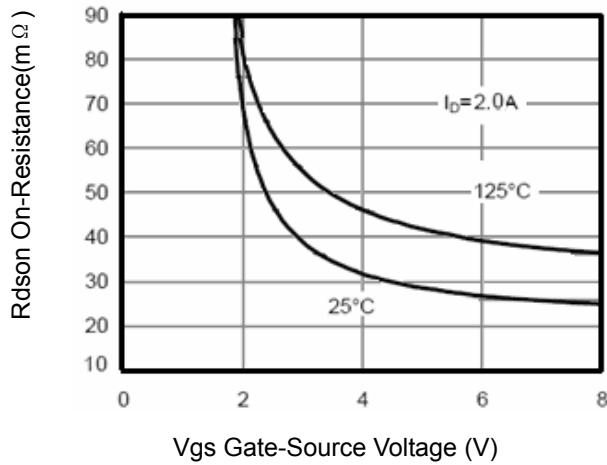
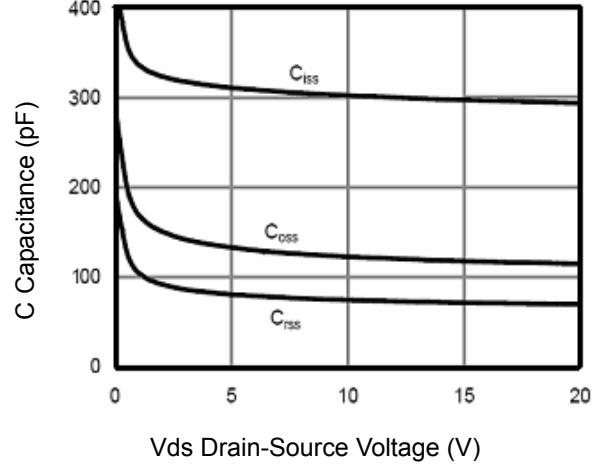
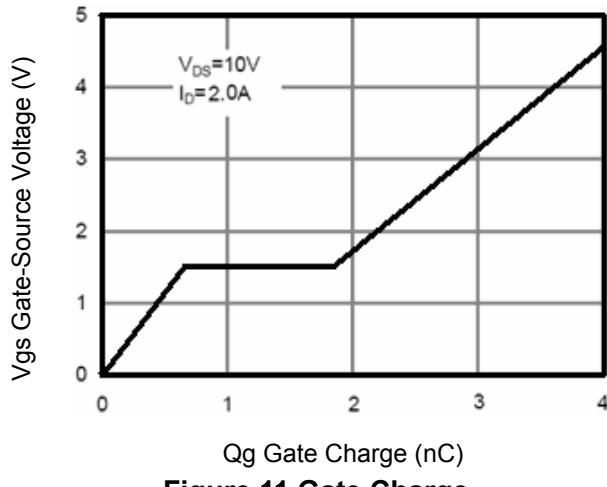
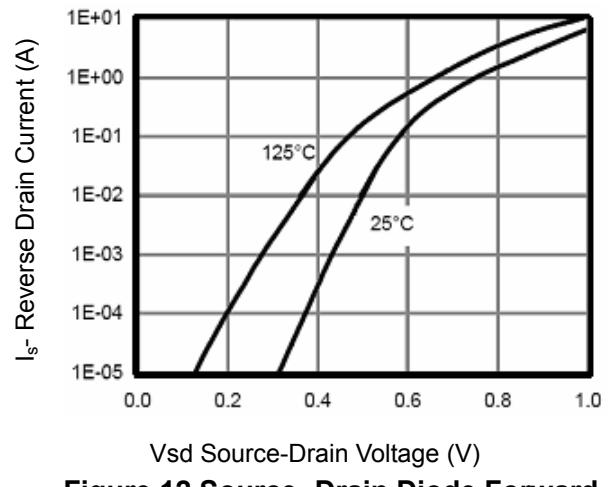
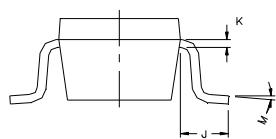
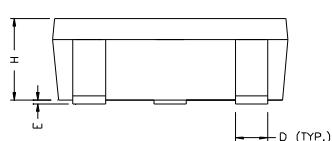
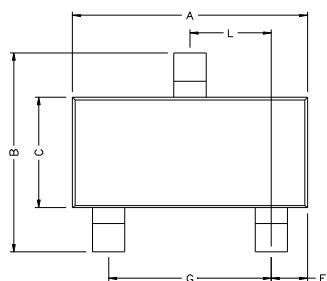


Figure 6 Drain-Source On-Resistance

**Figure 7 Transfer Characteristics****Figure 8 Drain-Source On-Resistance****Figure 9 Rdson vs Vgs****Figure 10 Capacitance vs Vds****Figure 11 Gate Charge****Figure 12 Source-Drain Diode Forward**

**Dimension outline** Unit:mm**SOT23**

REF.	Millimeter		REF.	Millimete	
	Min.	Max.		Min.	Max.
A	2.80	3.00	G	1.80	2.00
B	2.30	2.50	H	0.90	1.1
C	1.20	1.40	K	0.10	0.20
D	0.30	0.50	J	0.35	0.70
E	0	0.10	L	0.92	0.98
F	0.45	0.55	M	0°	10°

**SOT-23 Suggested Pad Layout**